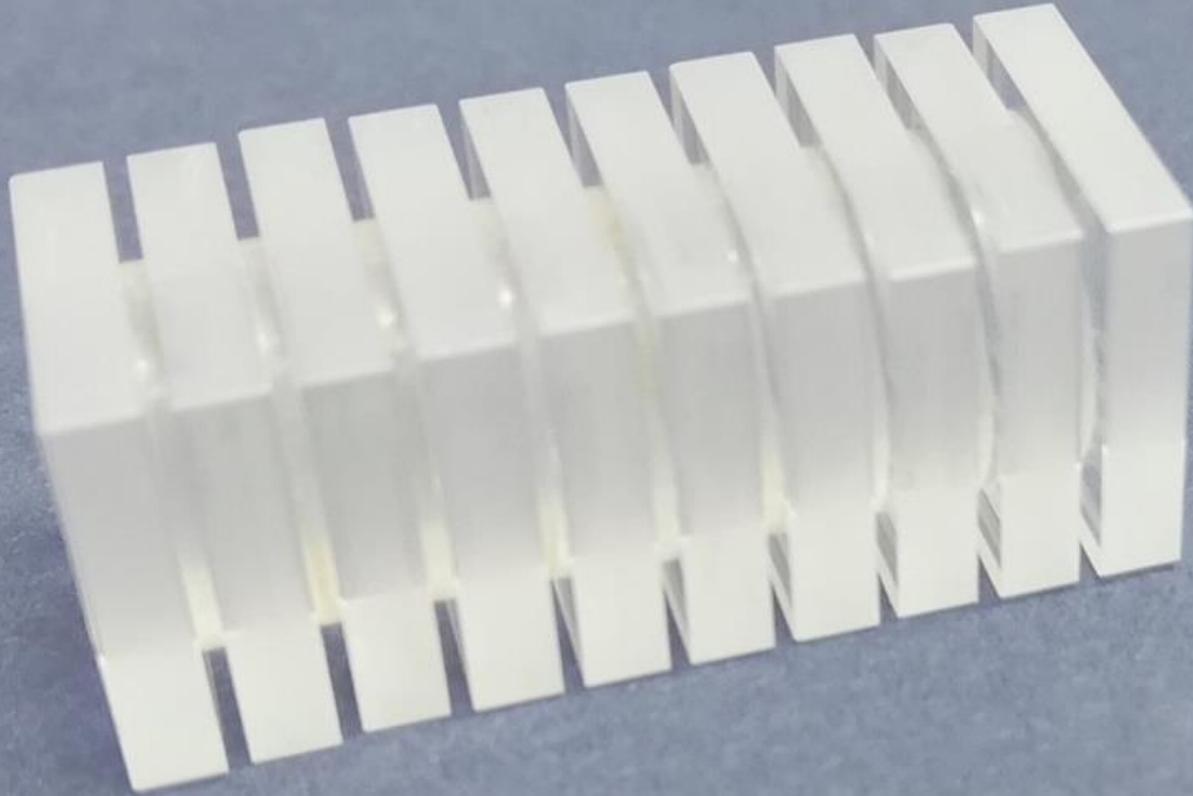


High energy laser amplifier by direct-bonded DFC chip

Arvydas Kausas

akausas@ims.ac.jp



Institute for Molecular Science, Okazaki

2020/07/08

Acknowledgements



<https://www.jst.go.jp/impact/sano/>

<https://www.jst.go.jp/impact/index.html>

<https://www.jst.go.jp/mirai/jp>

- This work was funded by ImPACT project, Program of Council for Science, Technology and Innovation (Cabinet Office, Government of Japan).
- This work was partially supported by JST-Mirai Program Grant Number JPMJMI17A1, JAPAN

Taira group, Okazaki



Taira lab group members

H. Ishizuki

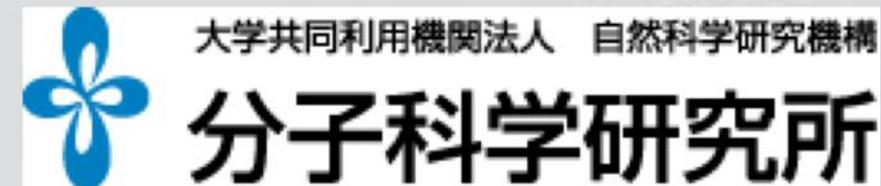
Y. Sato

V. Yahia

T. Kawasaki

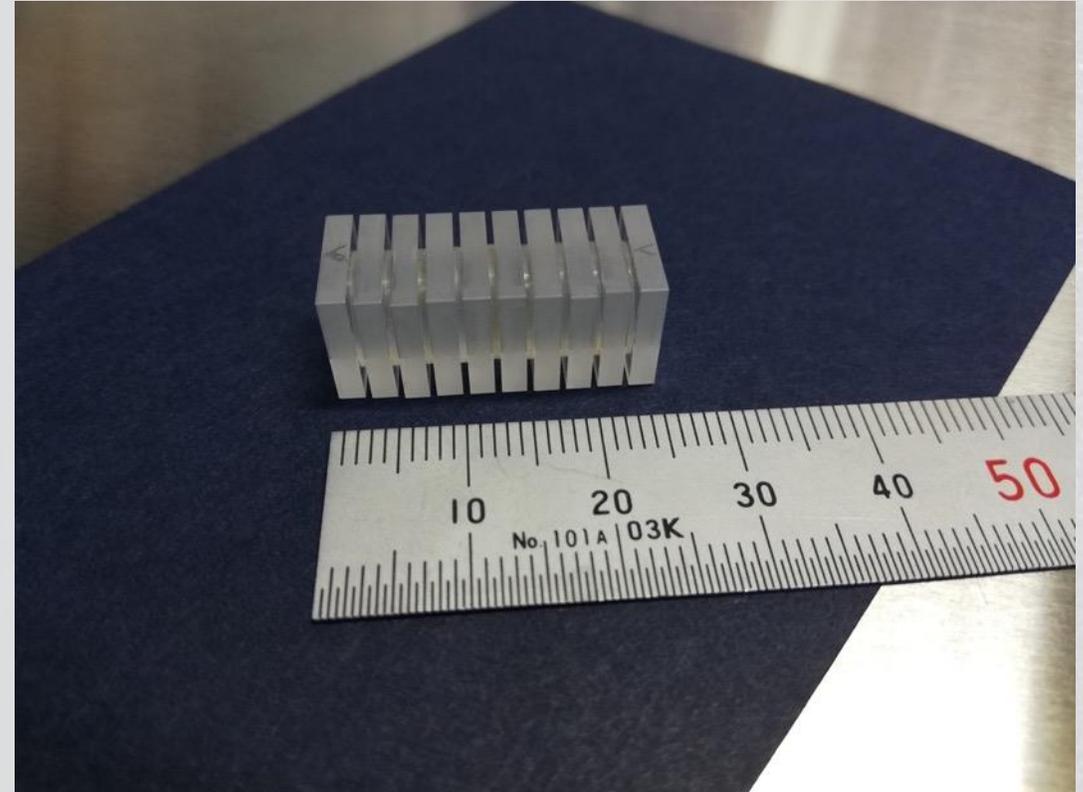
H. Lim

T. Kondo, for building bonding machine for Taira group



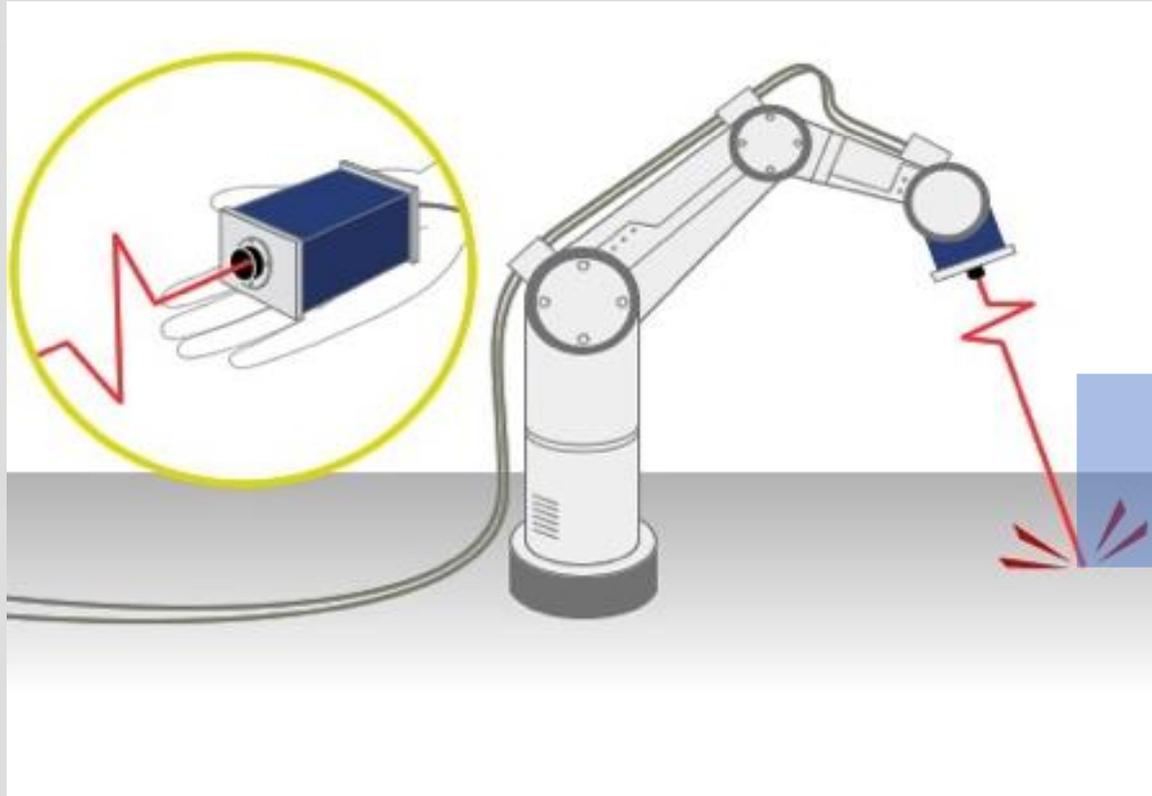
Outline

- Motivation
- DFC concept
- Surface activated bonding
- CW and pulse laser operation
- 300 mJ amplifier system
- Discussions
- Conclusions

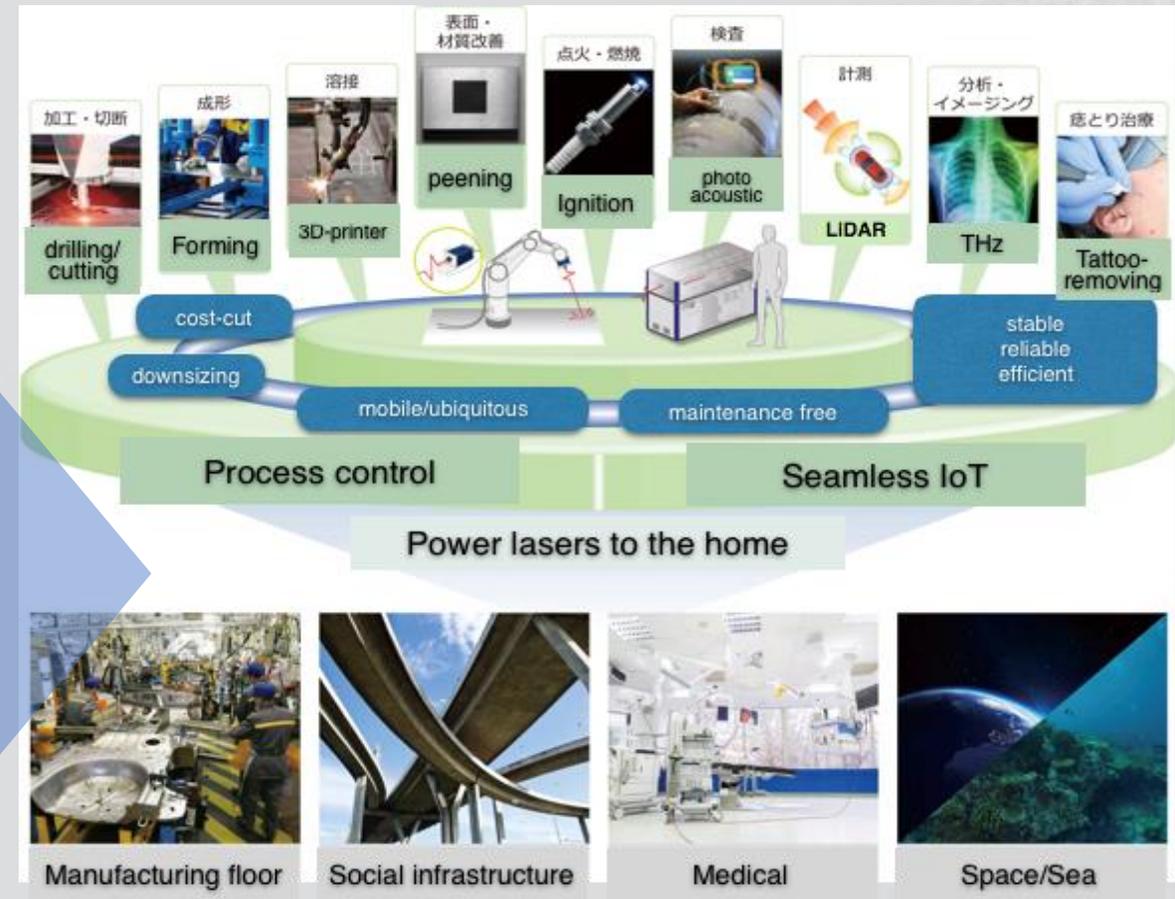


19-crystal composite chip comprised of sapphire and ceramic Nd³⁺:YAG crystals

Motivation for compact systems

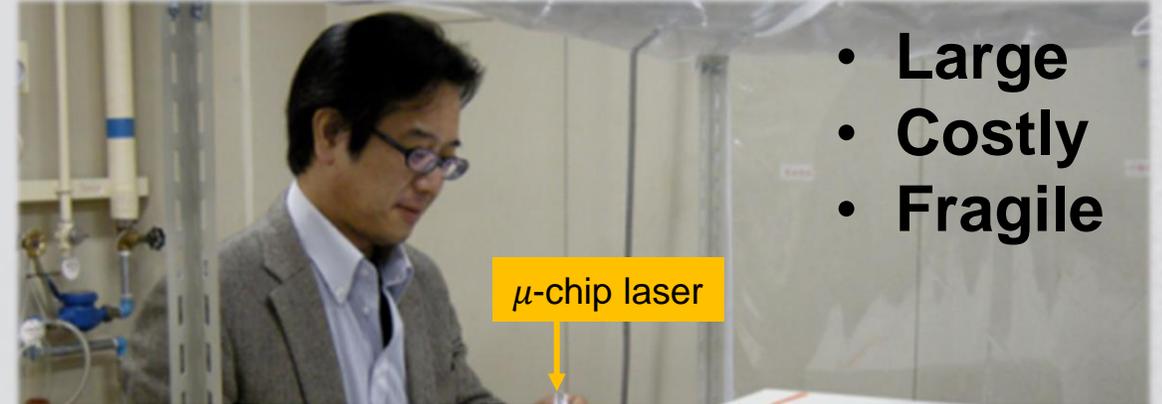
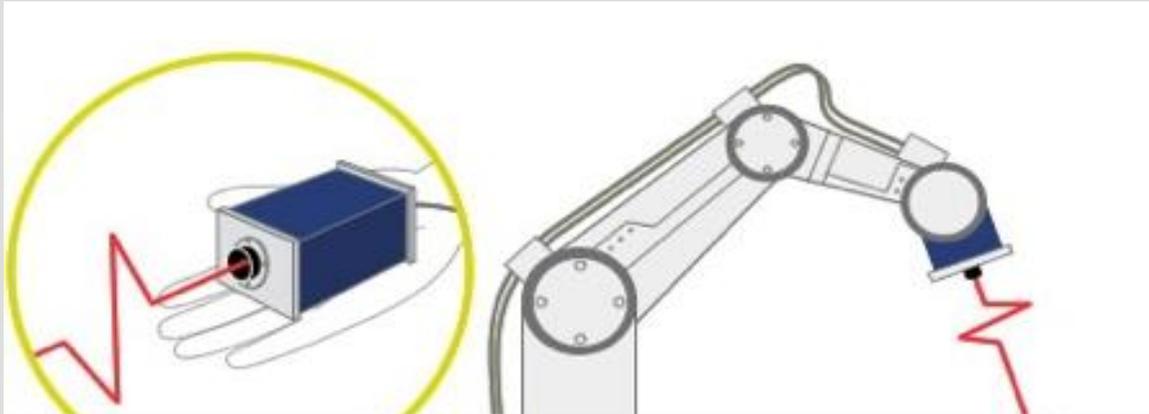


Tiny-integrated system



Ubiquitous power laser

Motivation for compact systems



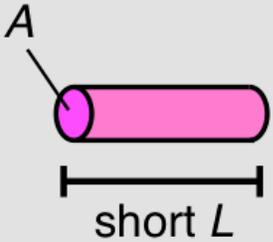
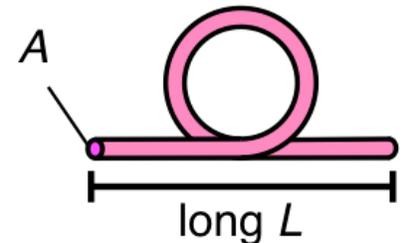
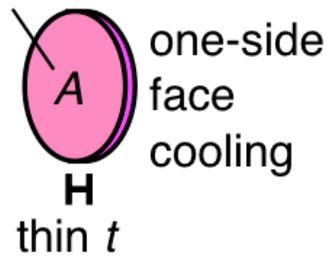
- Large
- Costly
- Fragile

OUR AIM

- Compact amplifier system
- Pulse energy = 2J
- Repetition rate = 100 Hz

Current limitation: heat generation

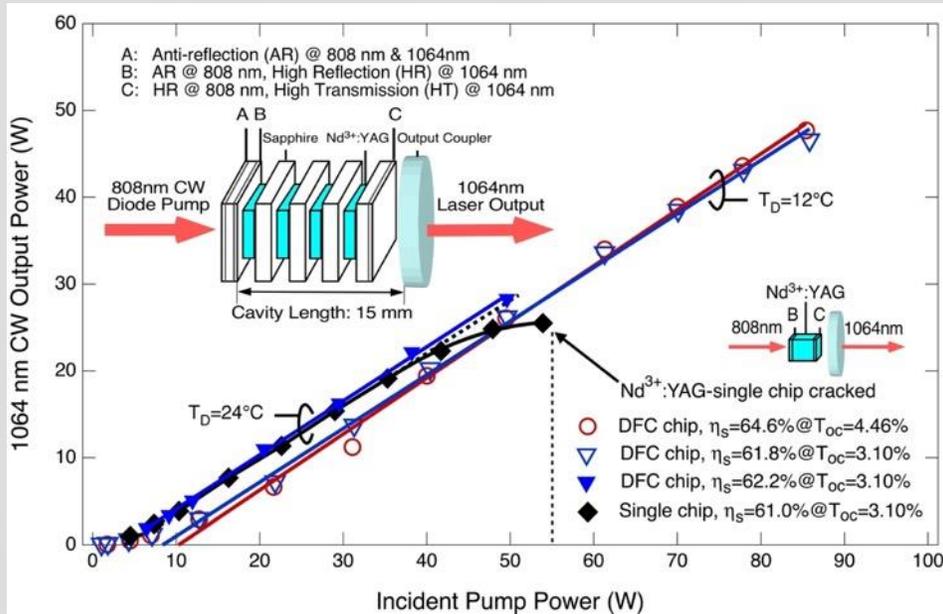
Power scalability for various laser configurations

Parameter	Shape		Thin disk	DFC
				
Maximum extractable power	$P_{ex} = \frac{8\pi R_T L}{\chi}$	$P_{ex} = \frac{8\pi R_T L}{\chi}$	$P_{ex} = \frac{12R_T}{\chi} \left(\frac{A}{t} \right)$	$P_{ex} = \frac{24NR_T}{\chi} \left(\frac{A}{t} \right)$
Power scalability	poor	high	medium	high
Gain	medium	high	poor	high
Damage threshold	medium	poor	high	high

DFC: distributed face cooling, R_T : thermal shock parameter, A : area of a gain medium, L : gain medium length, t : gain medium thickness, χ : heating parameter, N : number of chips or disks

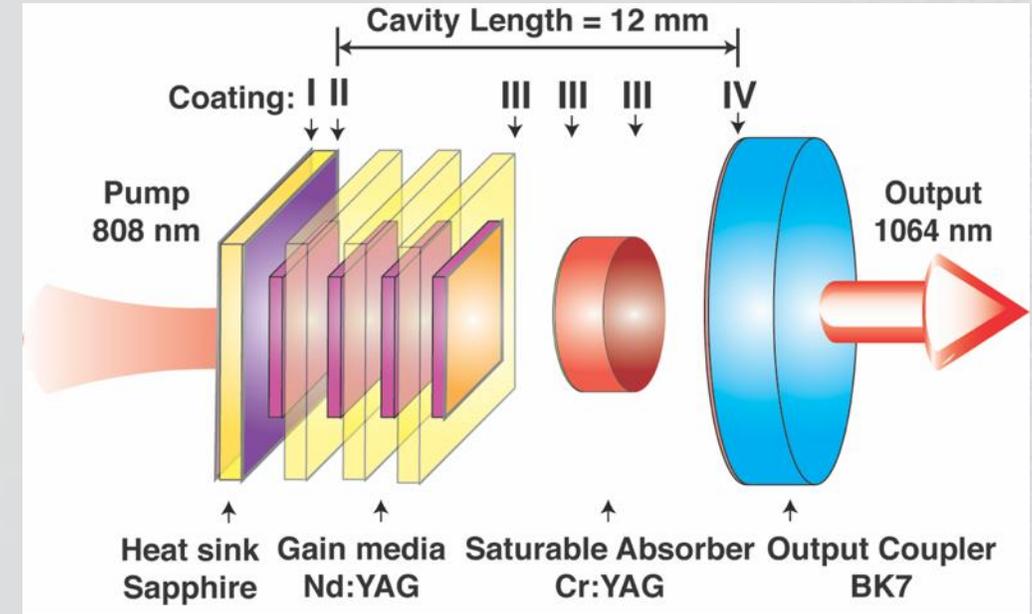
Research work based on DFC chip

CW operation



2x power increase compared to same gain length rod laser

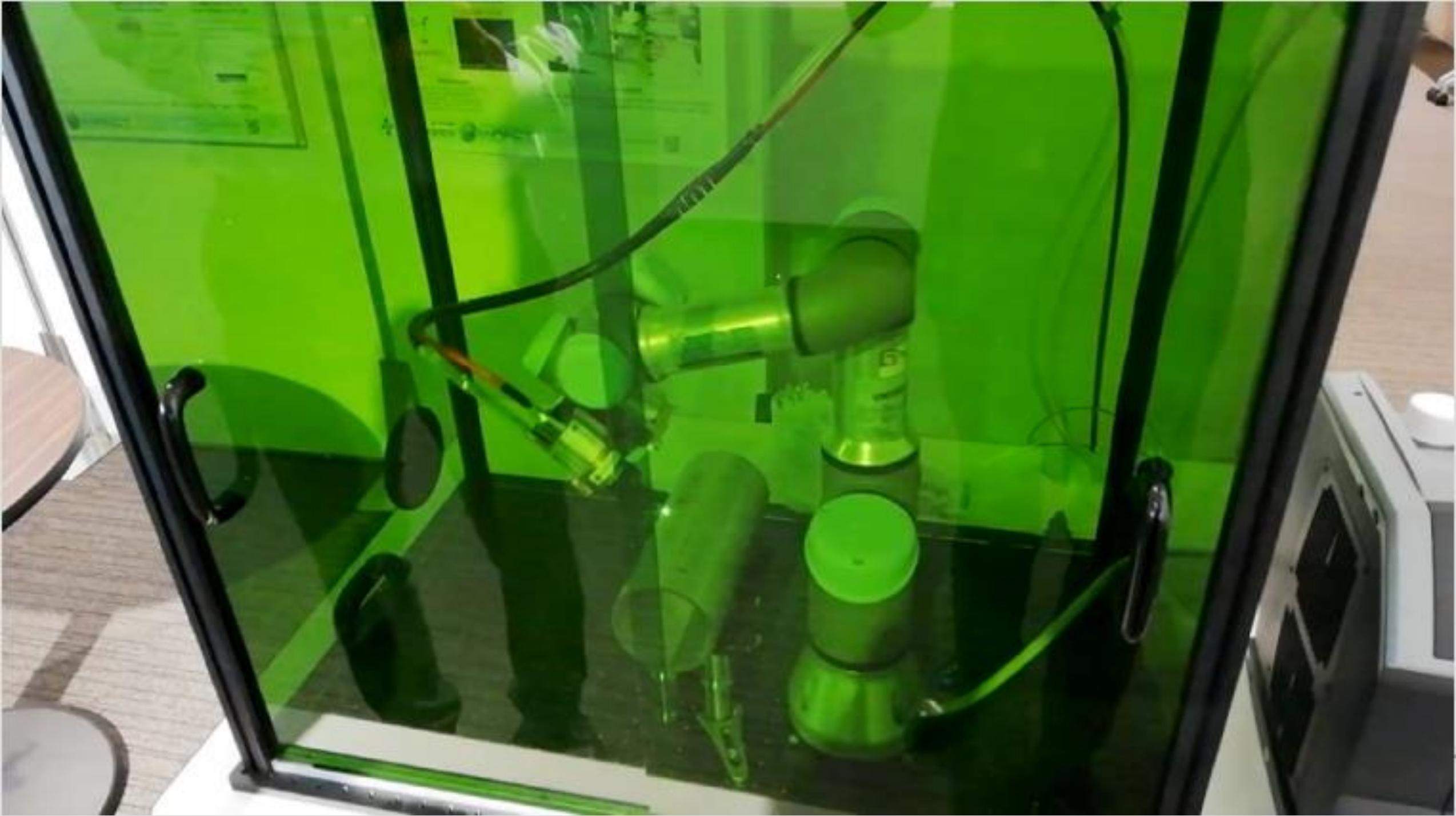
Pulsed operation



Energy 21.5 mJ
 Pulse duration <670 ps
 Peak power > 32 MW
 Rep. rate 10 Hz

Lihe Zheng, Arvydas Kausas, and Takunori Taira, "Drastic thermal effects reduction through distributed face cooling in a high power giant-pulse tiny laser," Opt. Mater. Express 7, 3214-3221 (2017)

Lihe Zheng, Arvydas Kausas, and Takunori Taira, ">30 MW peak power from distributed face cooling tiny integrated laser," Opt. Express 27, 30217-30224 (2019)



DFC concept

Maximum extractable power

For rod $P_{ex} = \frac{8\pi R_T L}{\chi}$

For disk $P_{ex} = \frac{12R_T}{\chi} \left(\frac{A}{t}\right)$

For DFC $P_{ex} = \frac{24NR_T}{\chi} \left(\frac{A}{t}\right)$

R_T – thermal shock parameter

A – area of gain medium

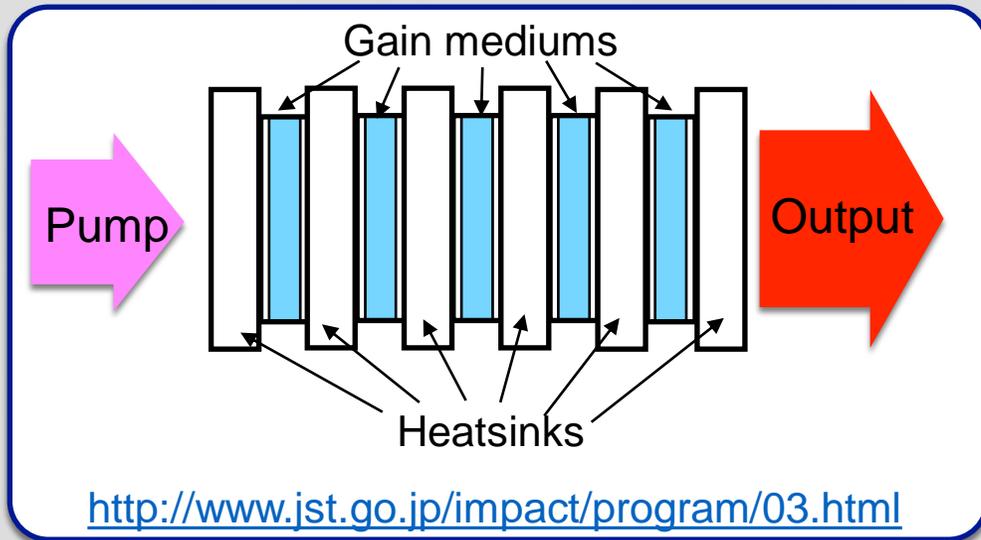
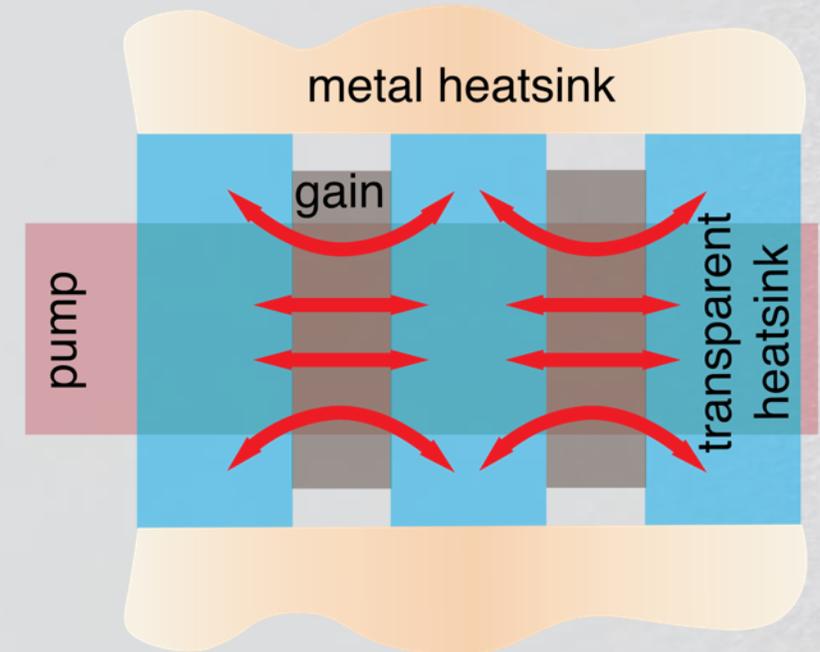
L – length of gain medium

t – gain thickness

χ – heating parameter

N – number of gain chips

Heat management



<http://www.jst.go.jp/impact/program/03.html>

Transparent heatsink

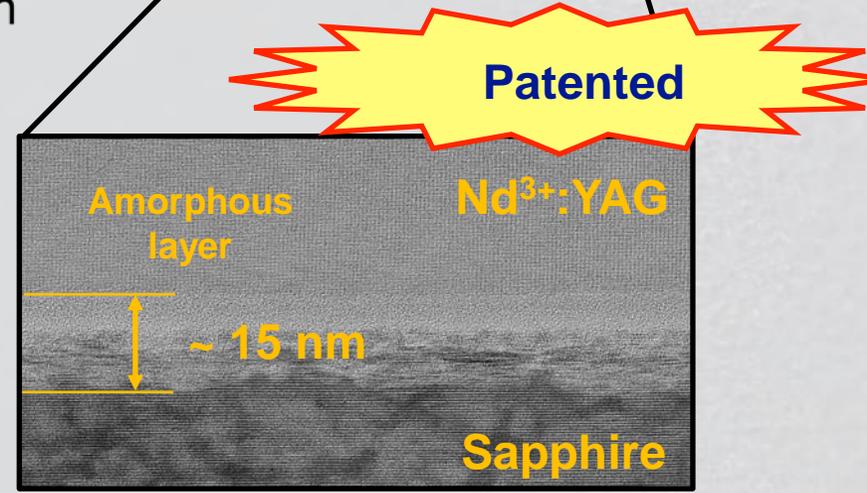
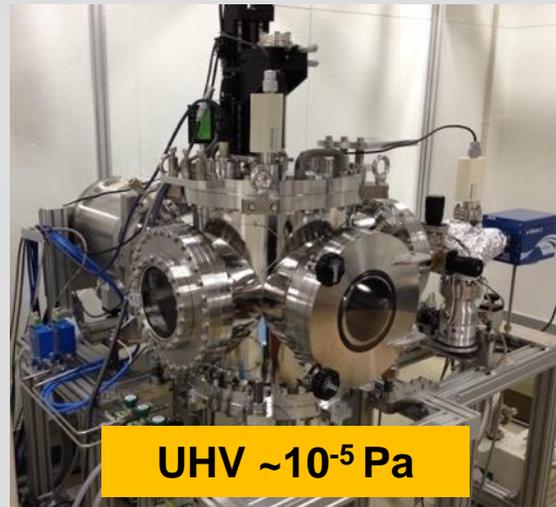
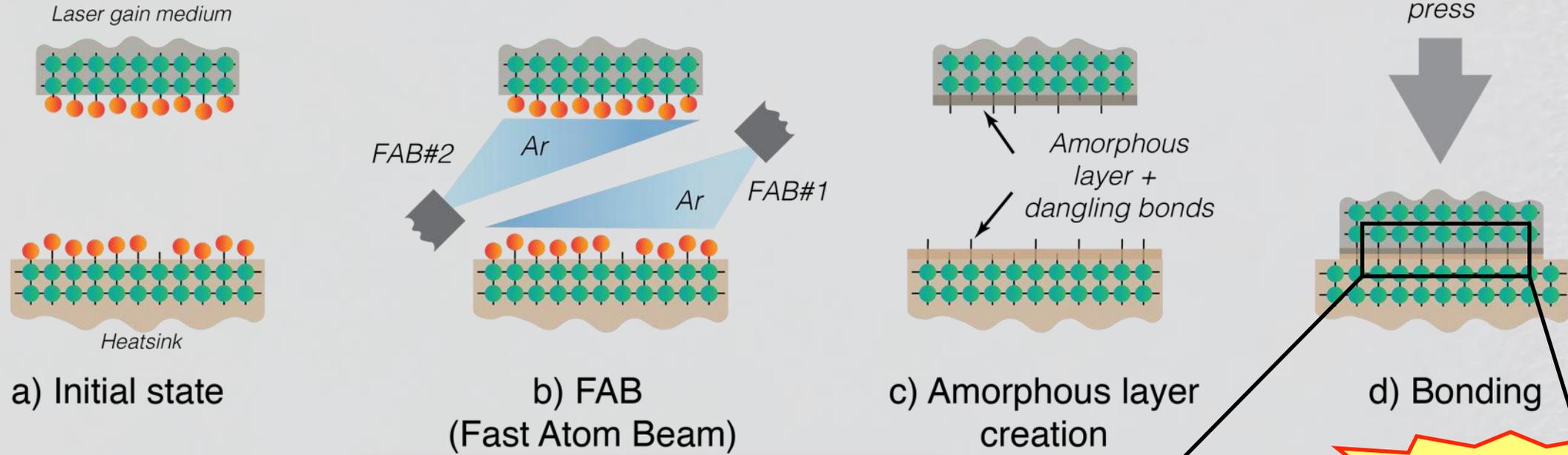
- YAG
- Sapphire
- Diamond

Gain medium

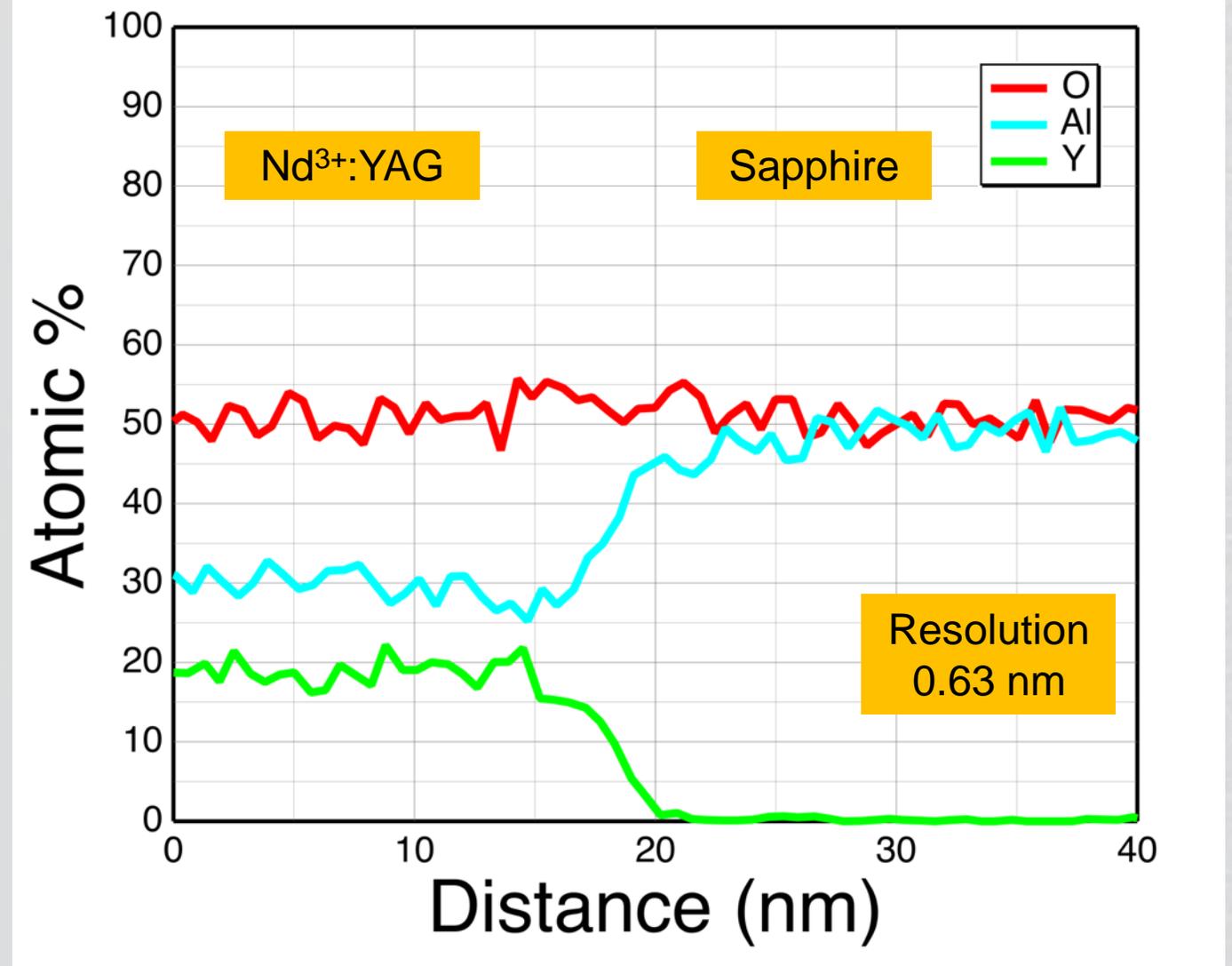
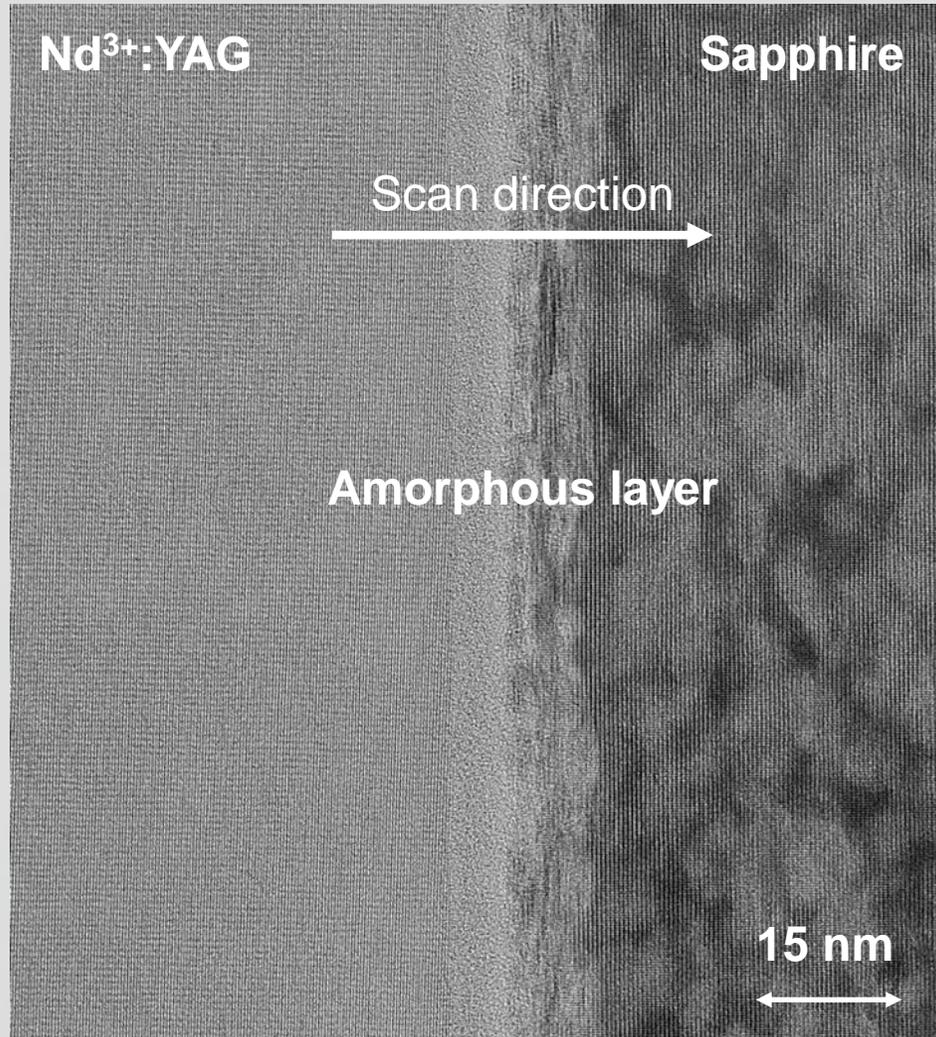
- Nd:YAG
- Yb:YAG
- Cr:YAG
- ...etc.

Surface Activated Bonding (SAB)

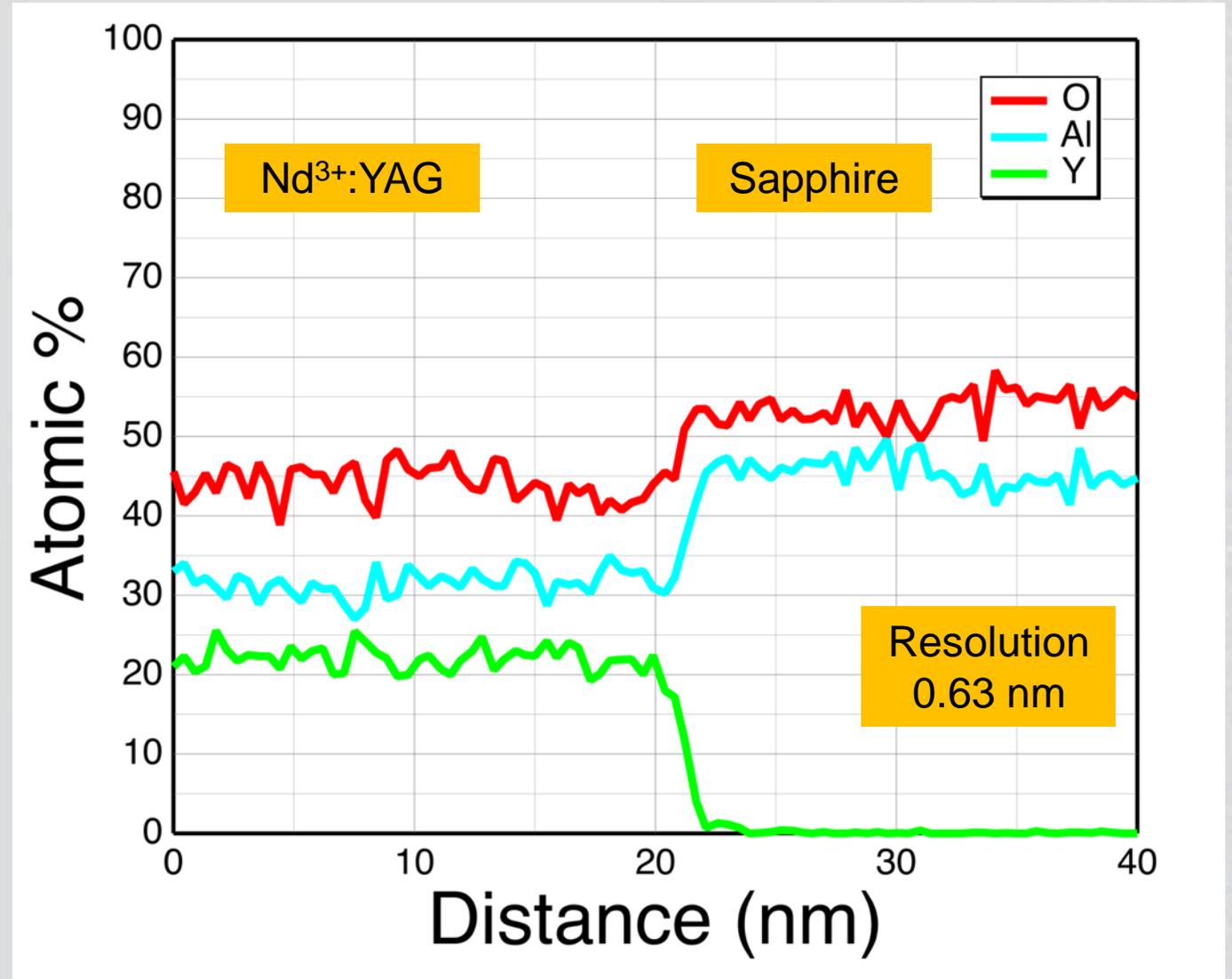
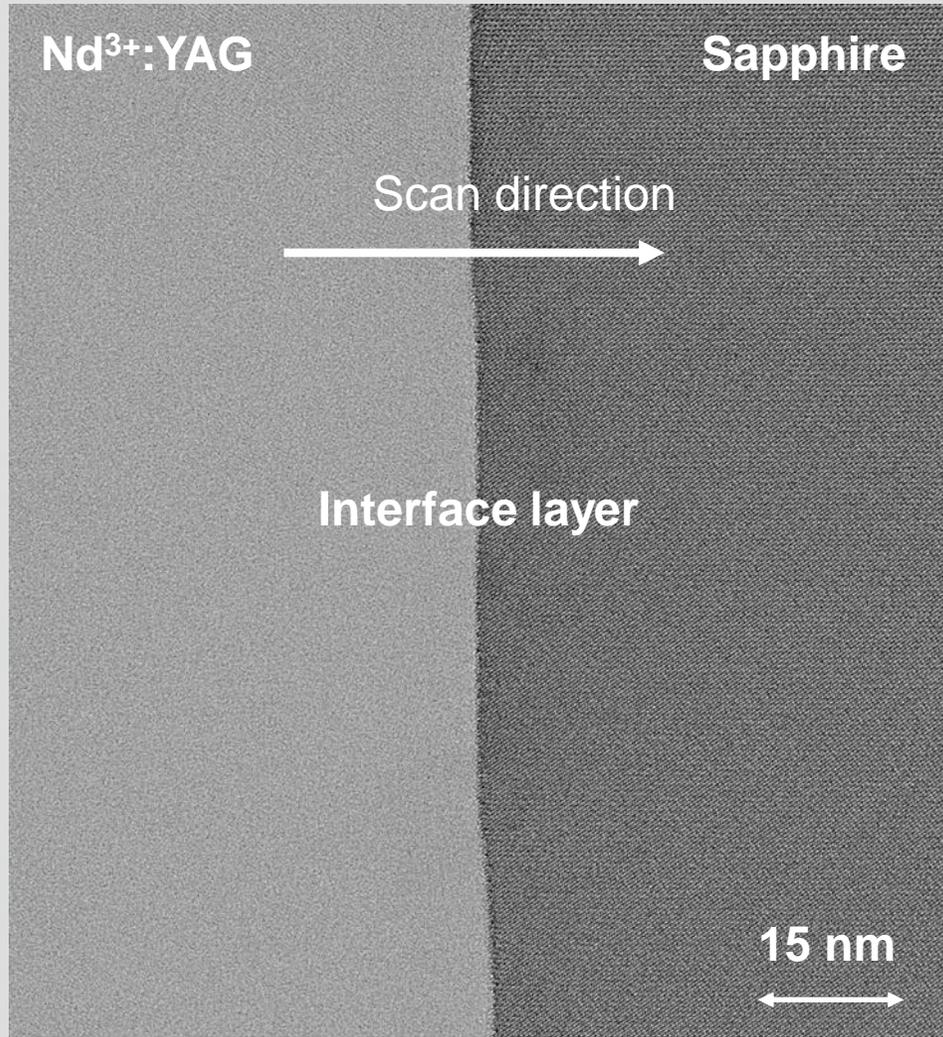
b) T. Suga et. al, *Acta Metall.Mater.* 40, S133-S137 (1992).
 c) L. Zheng et. al, *Optical Materials Express*, 7(9), 3214 (2017).



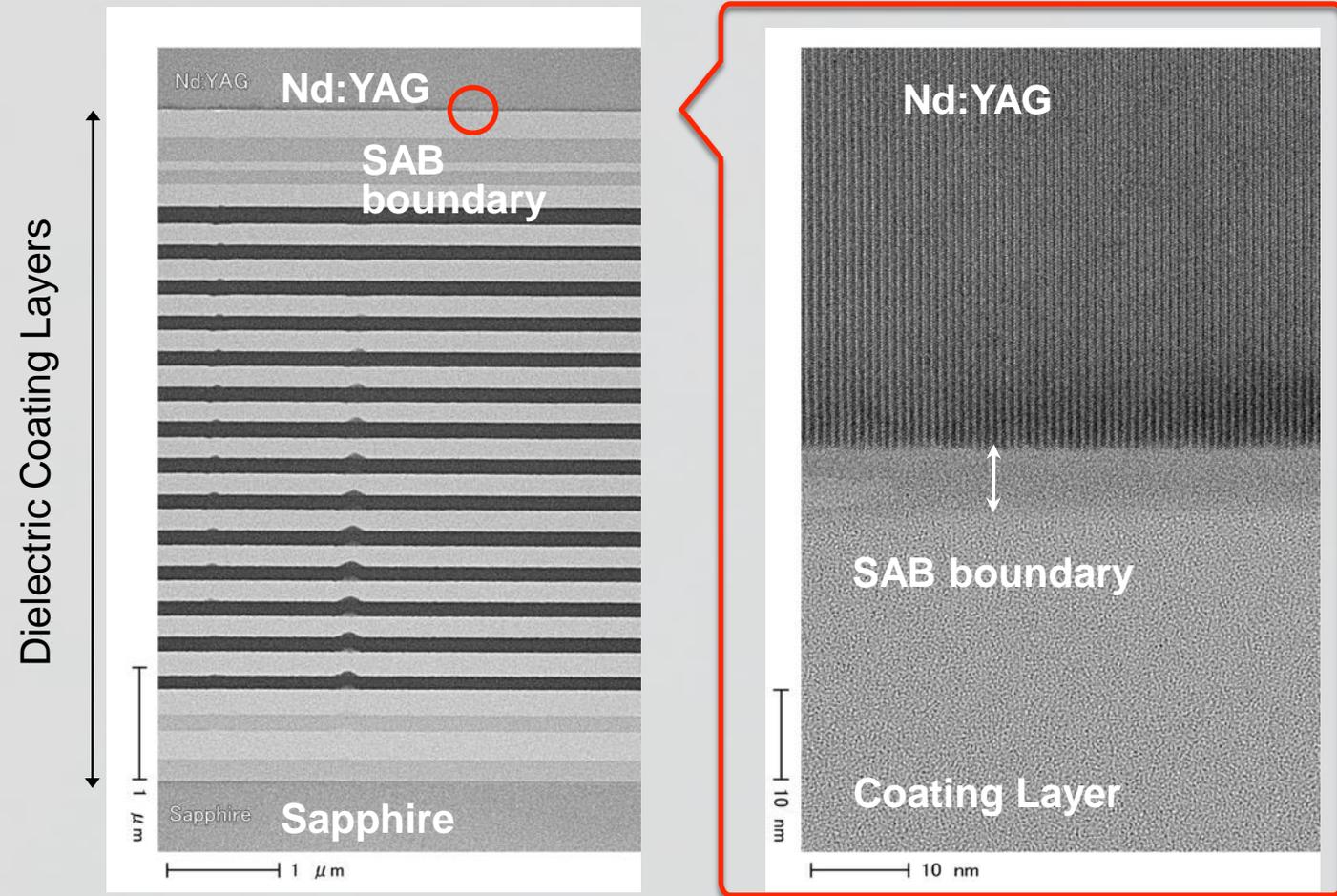
TEM and EDX measurements. Reference crystal



TEM and EDX measurements. Annealed crystal



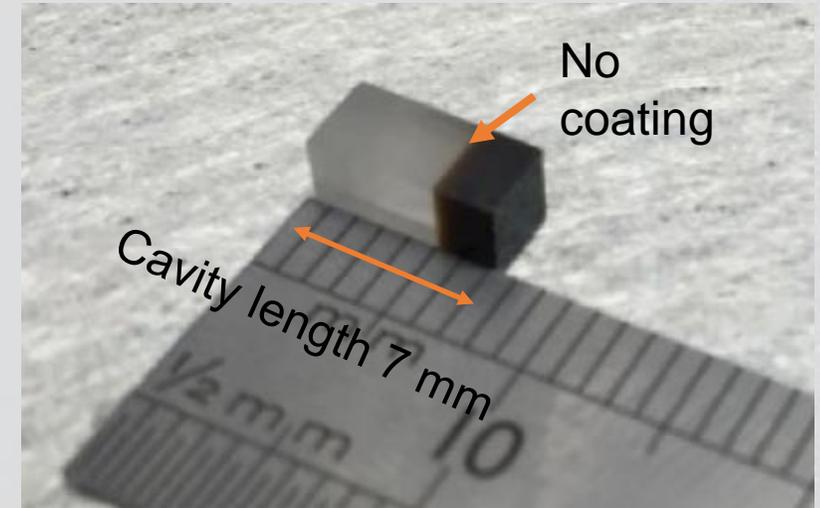
Coated material bonding



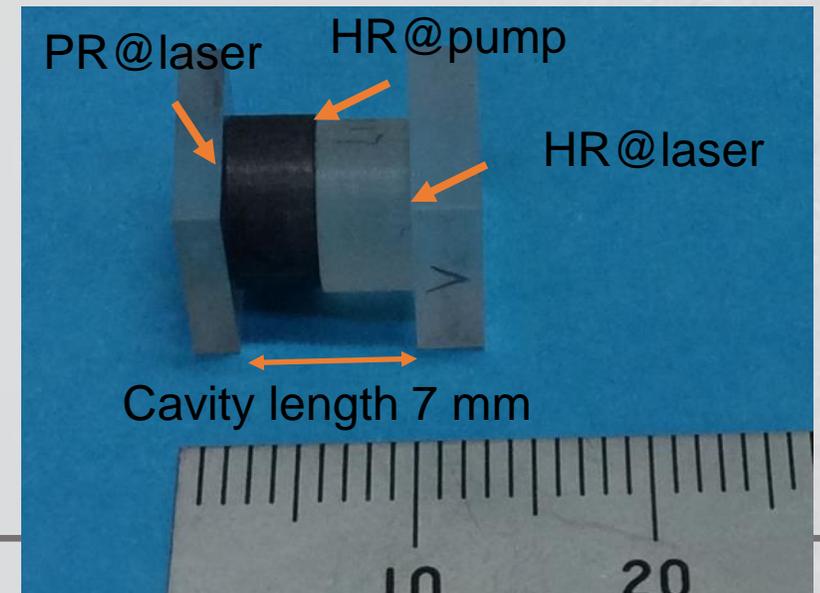
(a) Magnification : x 25,000 (b) Magnification : x 20,000,000

TEM analysis of SAB boundary: Coated samples

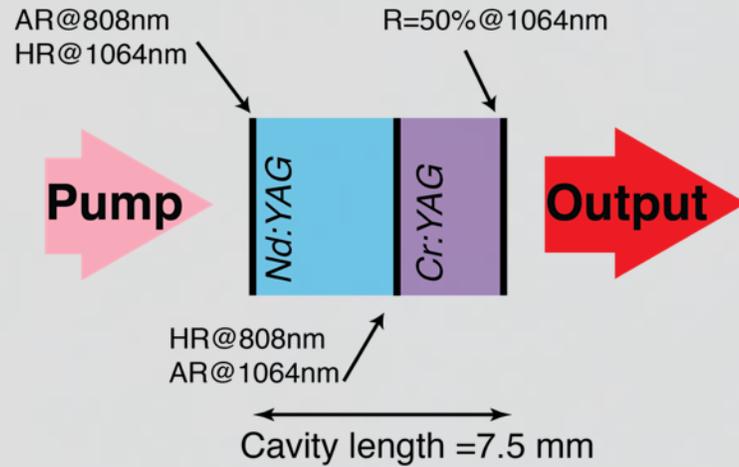
Ceramic crystal bond (diffusion bond)



Crystal bond (SAB, with interface coating)

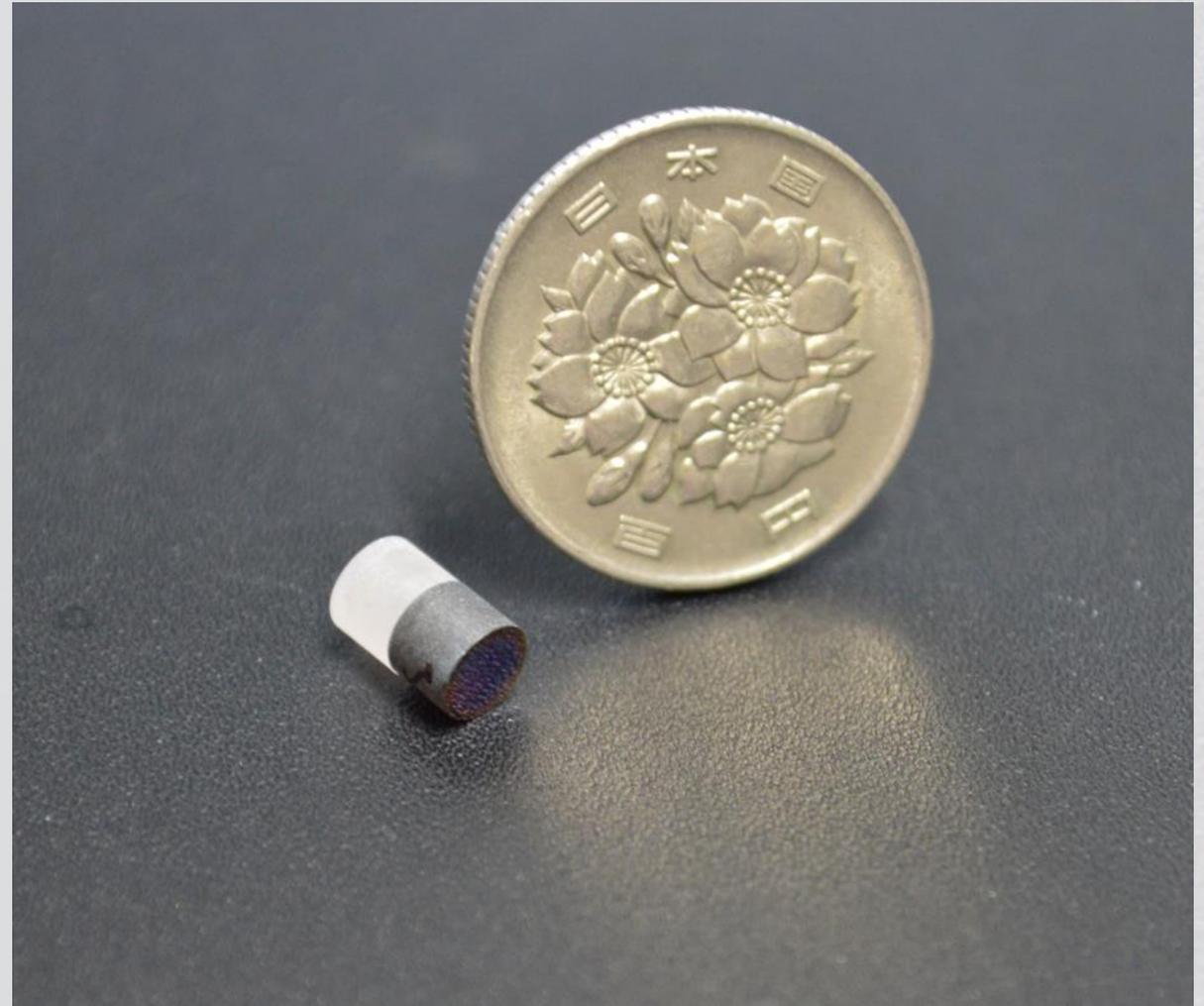


No end-cap composite chip

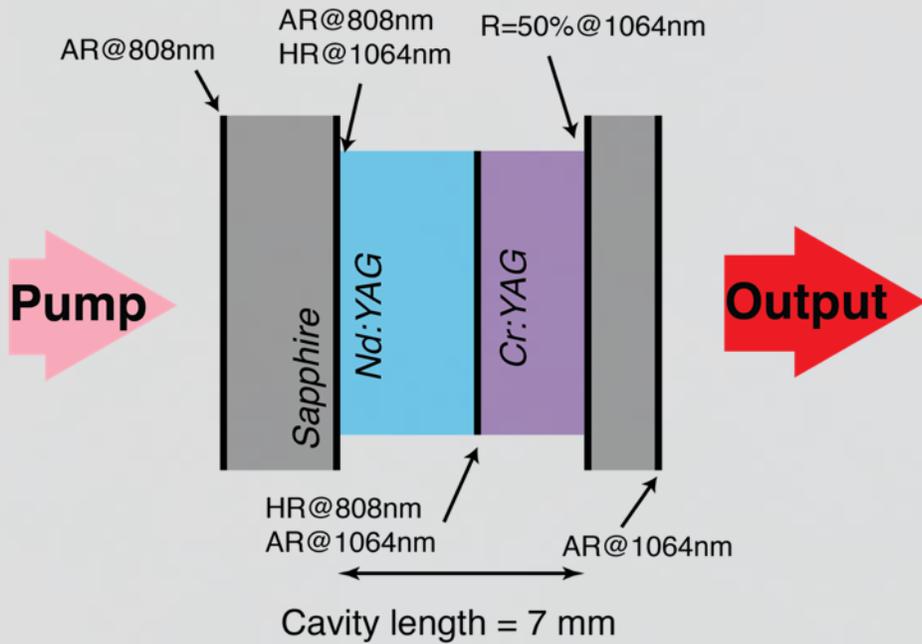


Nd:YAG, $\langle 111 \rangle$, 1.1-at.% $\varnothing 5 \times 4$ mm
Cr:YAG, $[110]$, $T_o = 30\%$ $\varnothing 5 \times 3.5$ mm

Pump Beam size: 0.77 mm
Pump peak power: 150 W
Pump pulse duration: 80 μs
Repetition rate: 100-1000 Hz

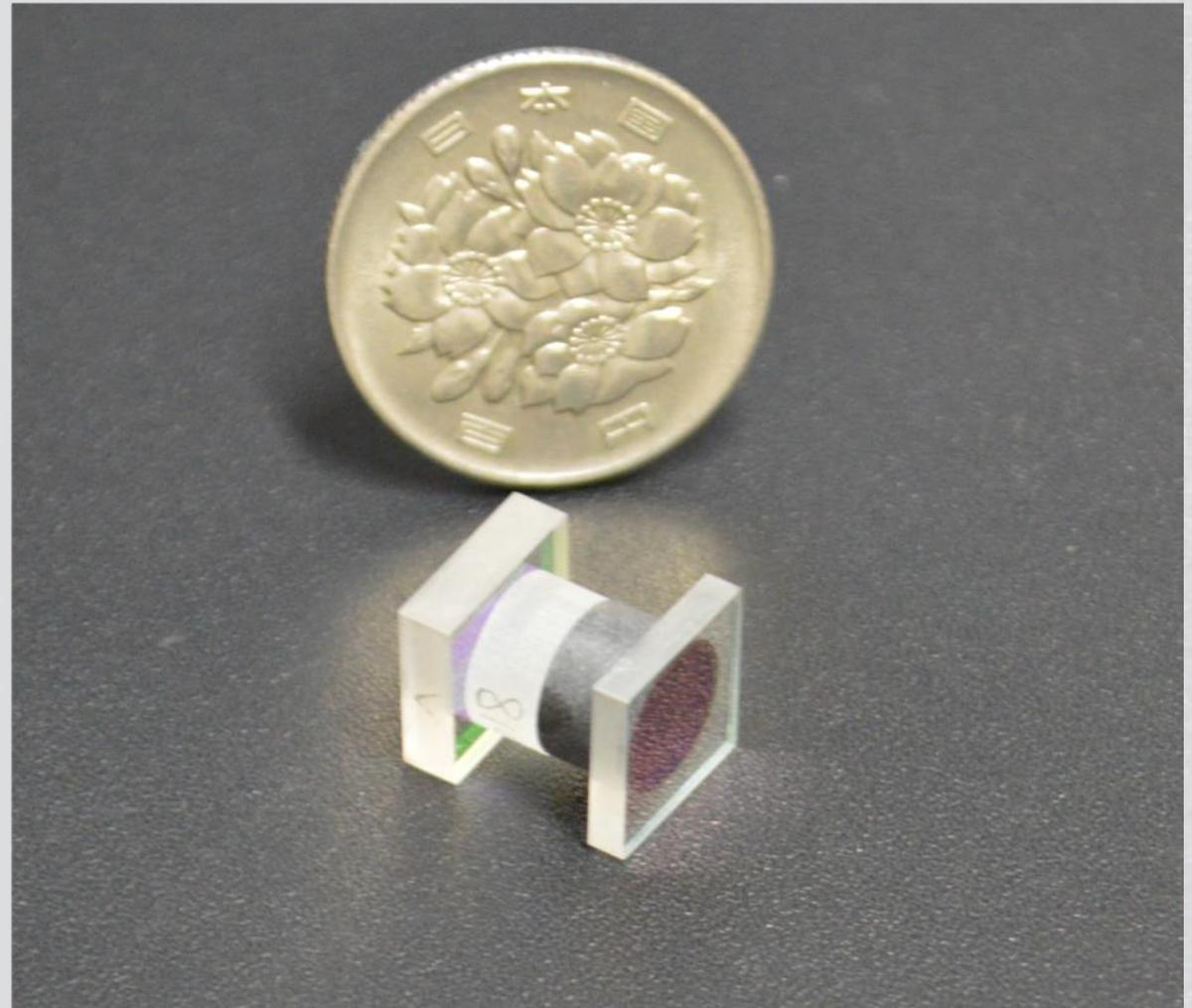


With end-cap composite chip



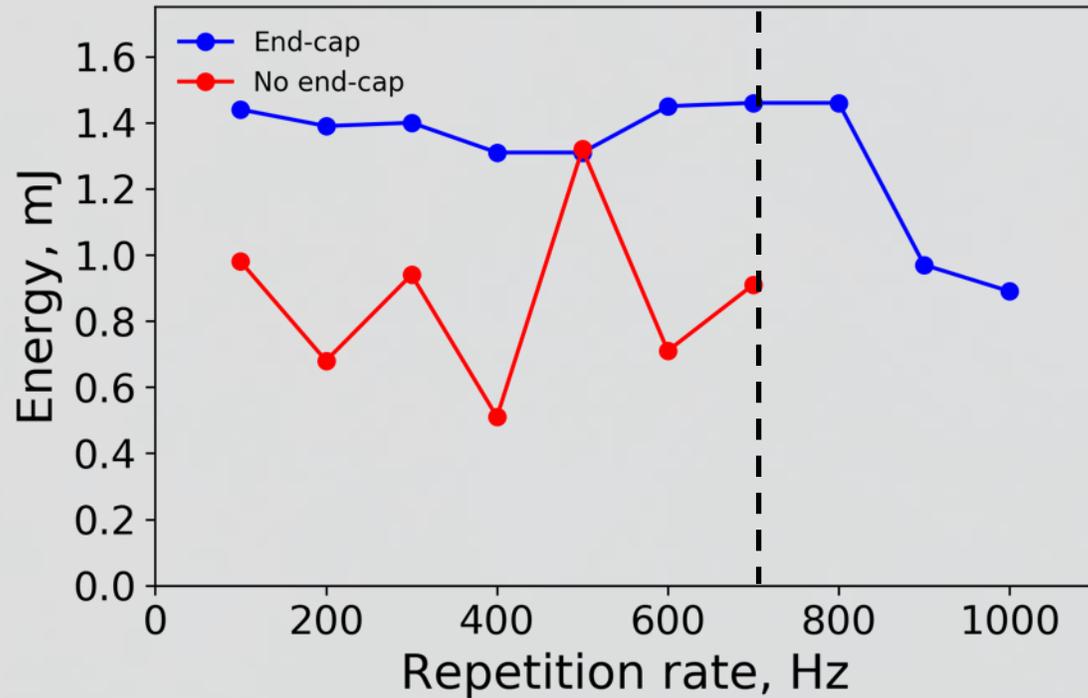
Sapphire, c-cut $10 \times 10 \times 2-3 \text{ mm}^3$
Nd:YAG, <111>, 1.1-at.% $\varnothing 8 \times 4 \text{ mm}$
Cr:YAG, [110], $T_o = 30\%$ $\varnothing 8 \times 3 \text{ mm}$

Pump Beam size: 0.77 mm
Pump peak power: 150 W
Pump pulse duration: 80 μs
Repetition rate: 100-1000 Hz

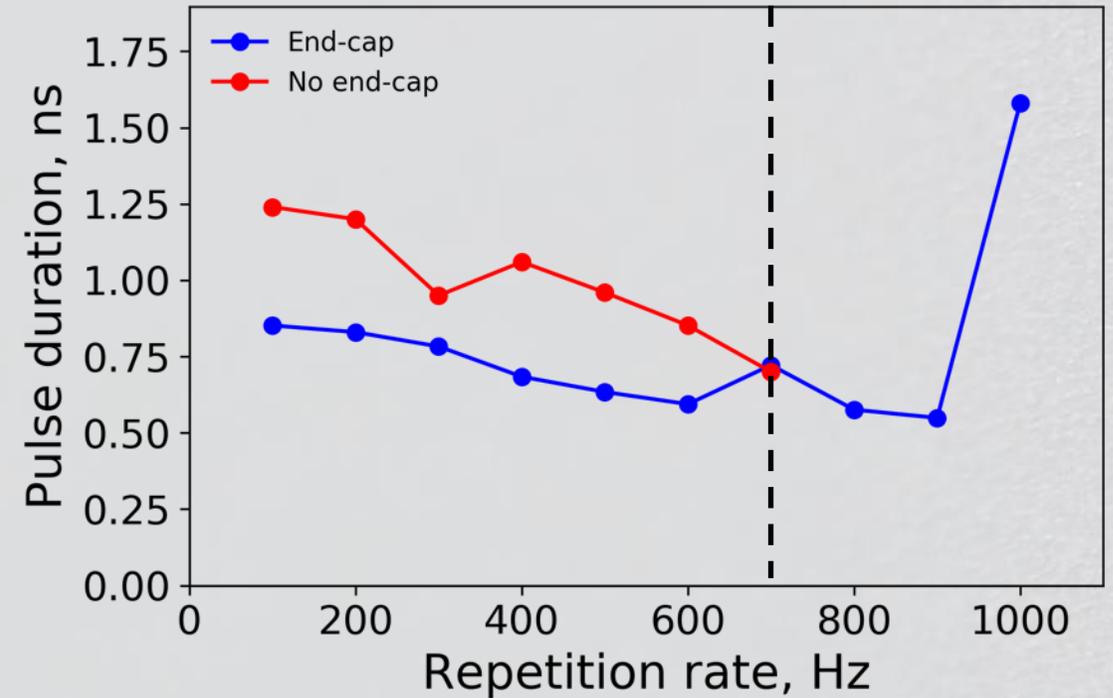


Output parameters. Pulse energy and duration

Pulse energy



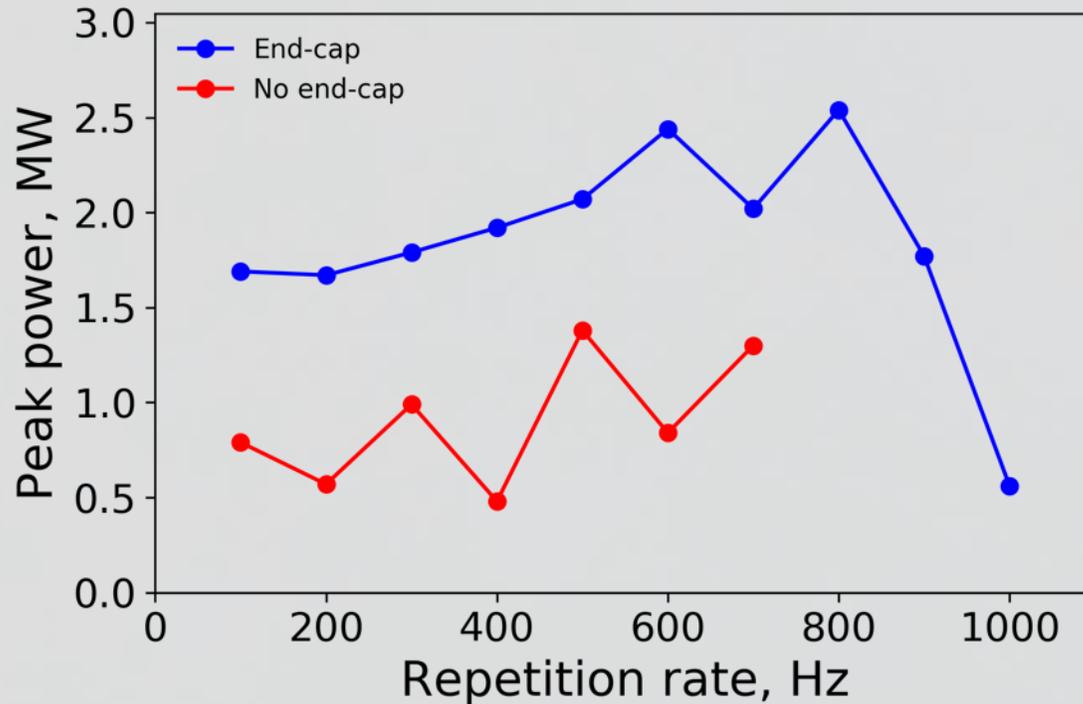
Pulse duration



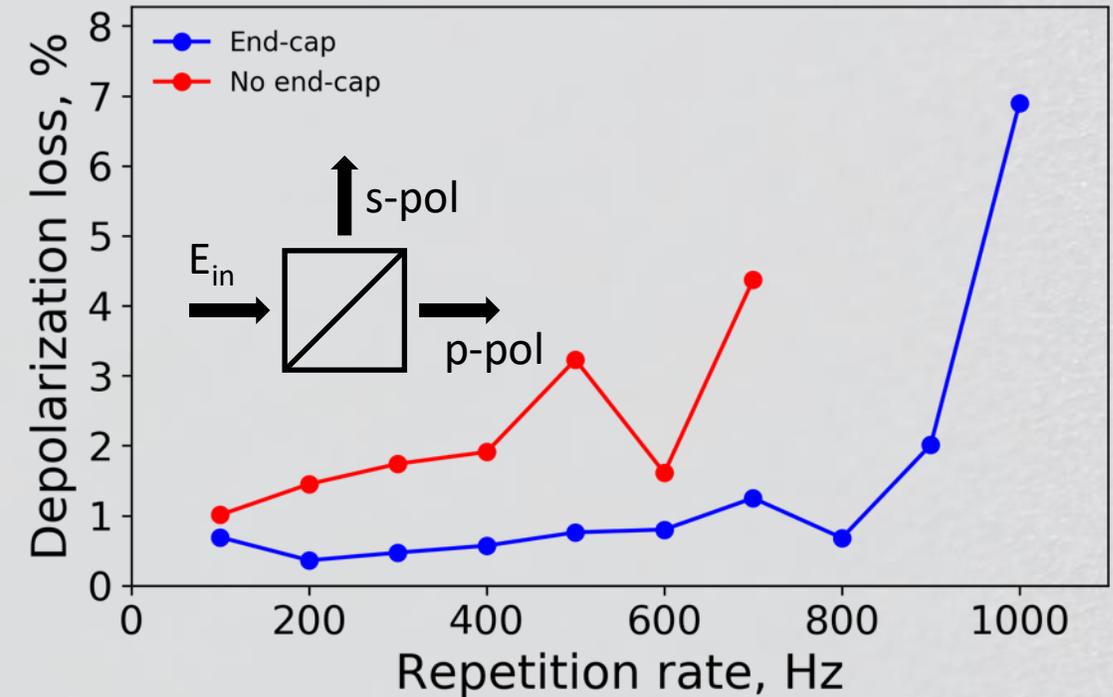
- No data after this 700 Hz for no end-cap case
- Heat generation increased

Output parameters. Pulse peak power and depolarization loss

Peak power



Depolarization loss

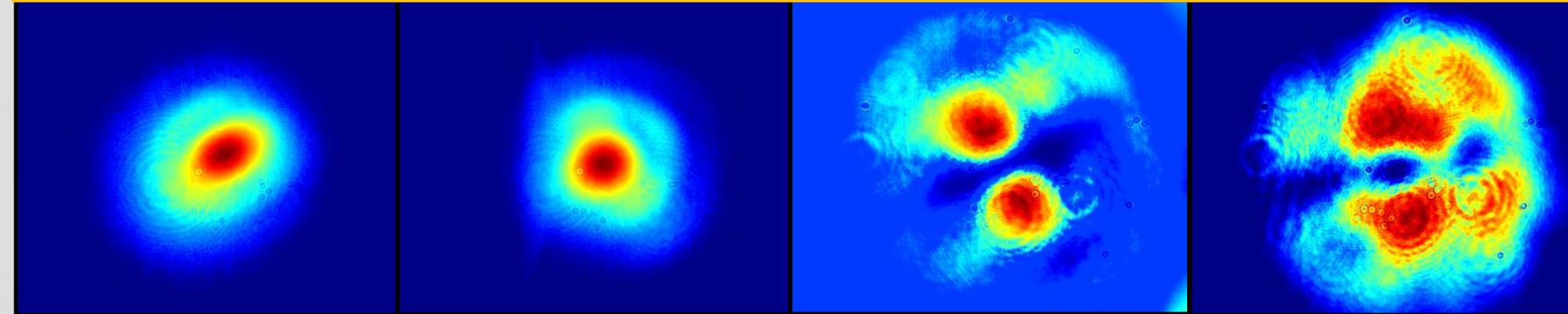


- No data after this 700 Hz for no end-cap case
- Heat generation increased

$$D_{loss} = \frac{s - pol}{(s - pol) + (p - pol)}$$

Beam profile at different repetition rates values

No end-cap composite chip



100 Hz

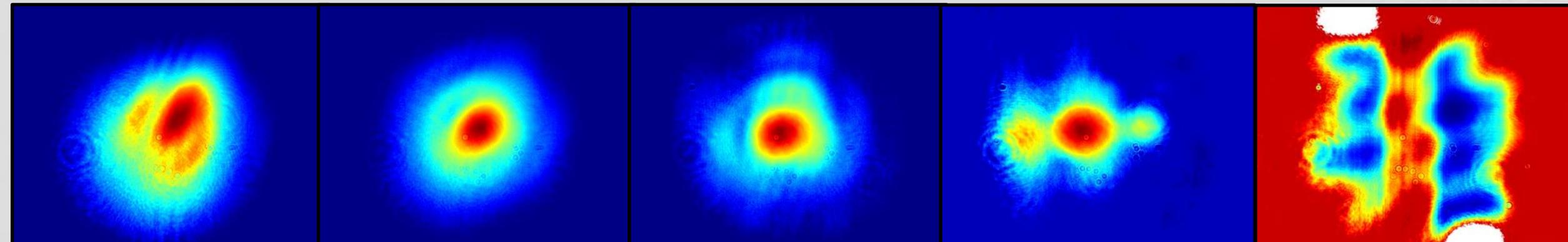
300 Hz

500 Hz

700 Hz

1000 Hz

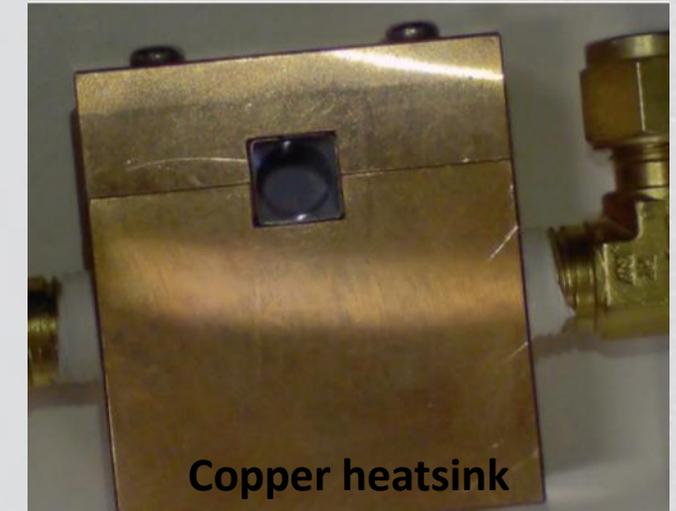
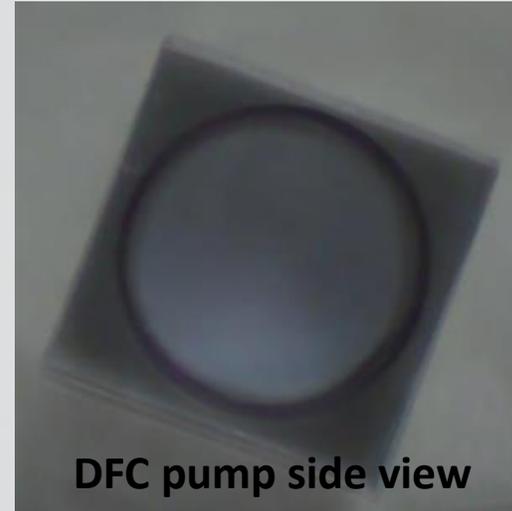
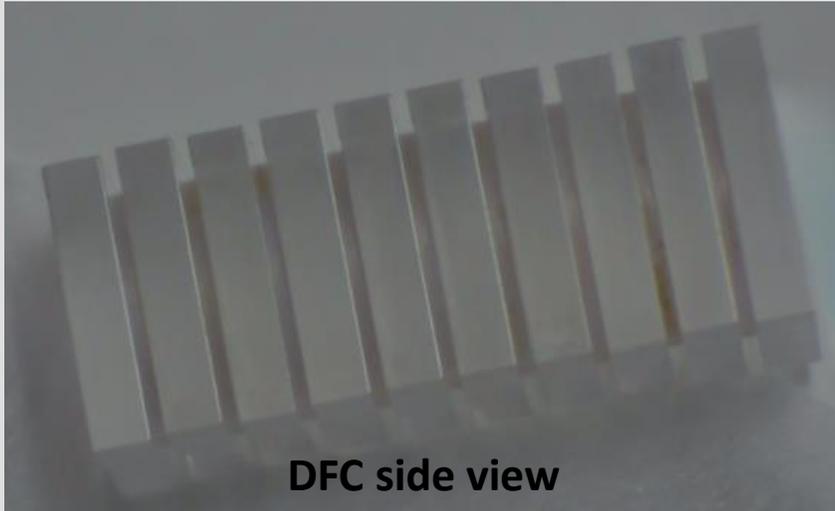
No possibility
to align the
cavity



End-cap composite chip

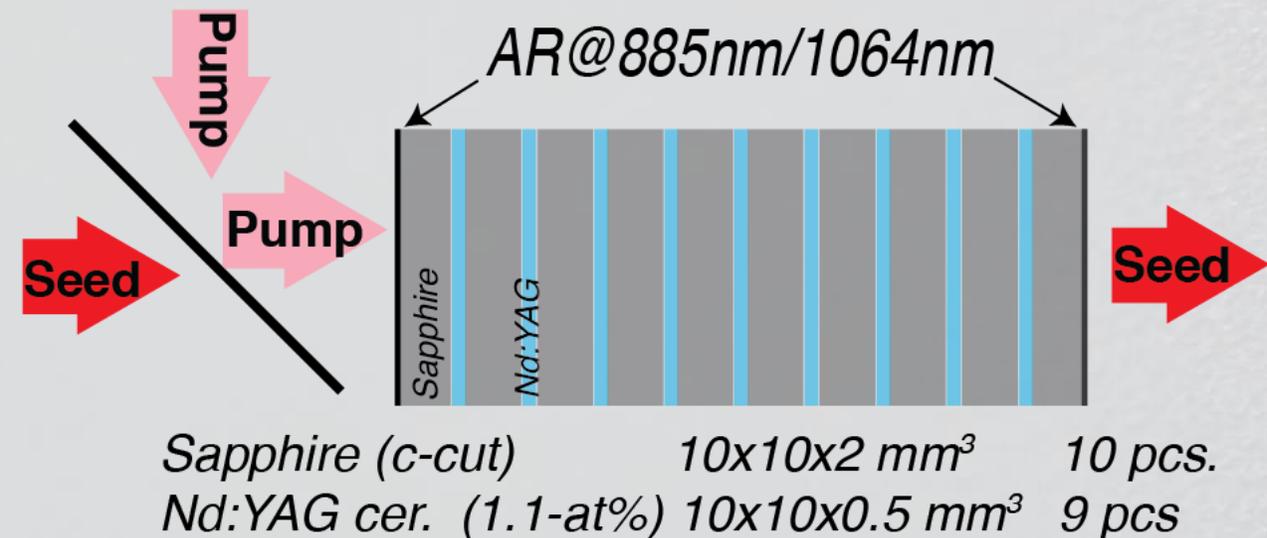
Amplifier setup (High Energy Accelerator Research Organization, KEK)

With prof. M. Yoshida group

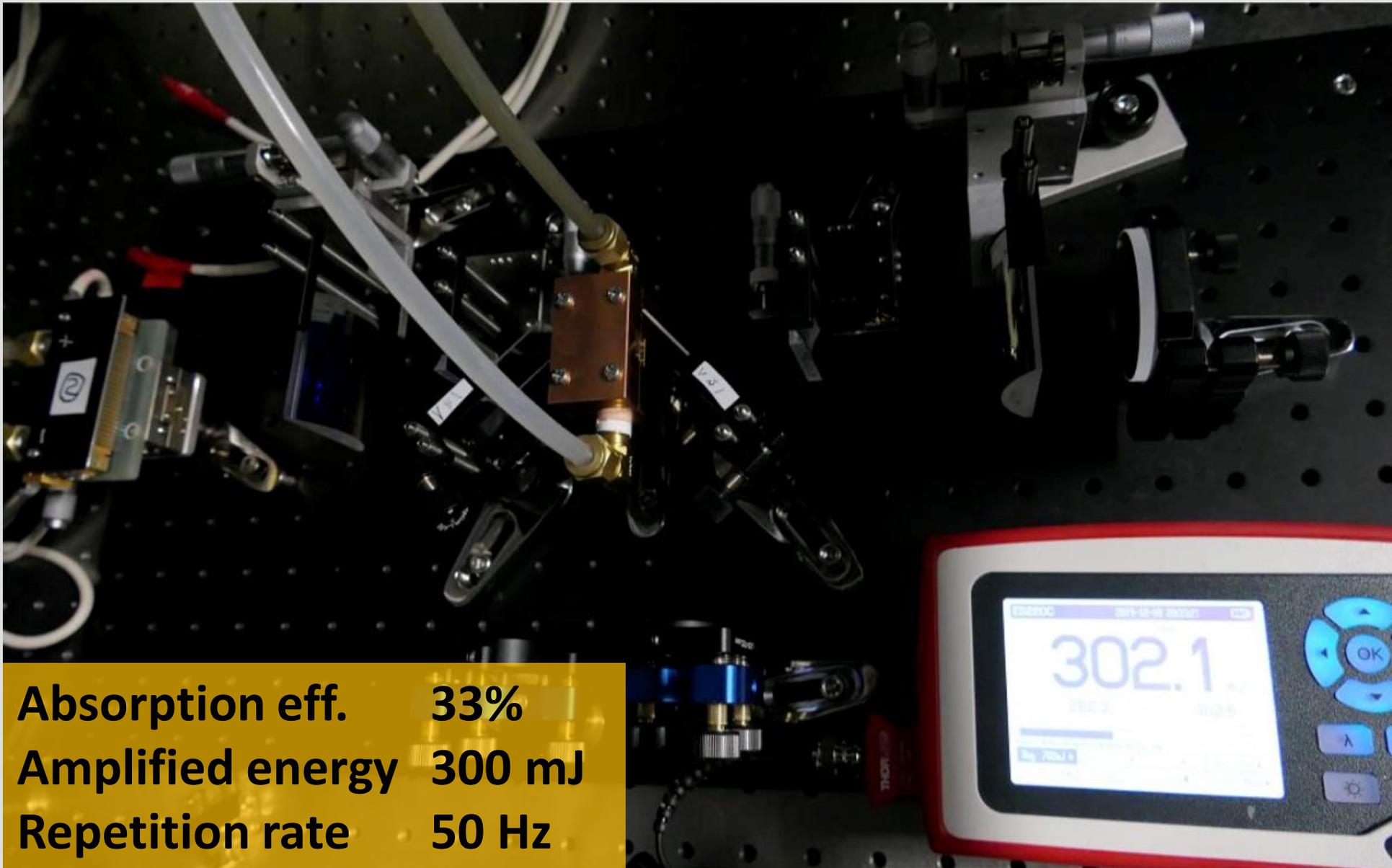


Pump parameters:

Pump power	8.85 kW
Pulse duration	250 μ s
Pump energy	2.2 J
Rep. rate	10-50 Hz



Experimental results



Finite element analysis calculation

degC

Pump beam profile:

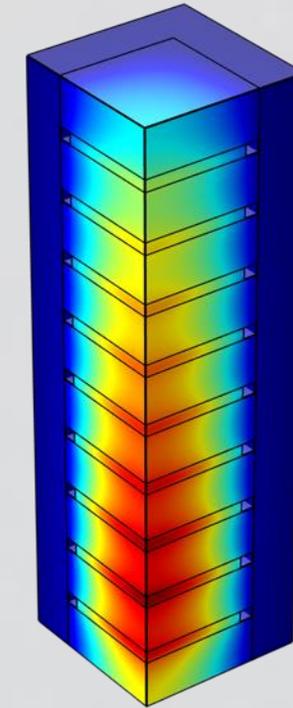
- Top-Hat profile
- Beam waist is constant along the crystal, $2w = 10$ mm

Absorption coefficient in Nd³⁺:YAG crystal:

- Absorption coefficient is constant and does not depend on a temperature, $\alpha = 1.5$ cm⁻¹
- No pump saturation occur* ($I_{pump} \ll I_{saturation,pump}$)

Fractional heat load:

- η_h equal to 0.317

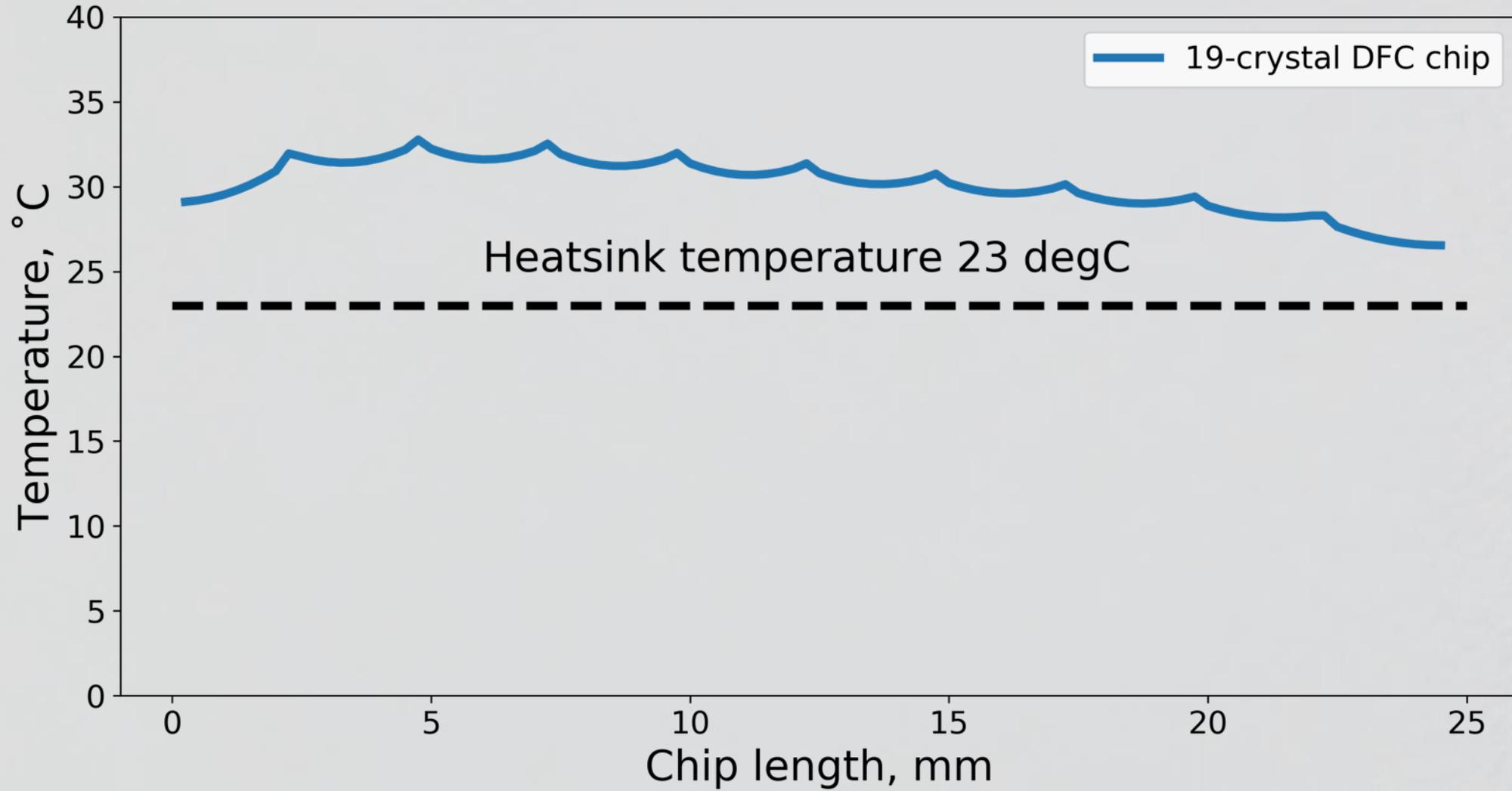


50 Hz repetition rate

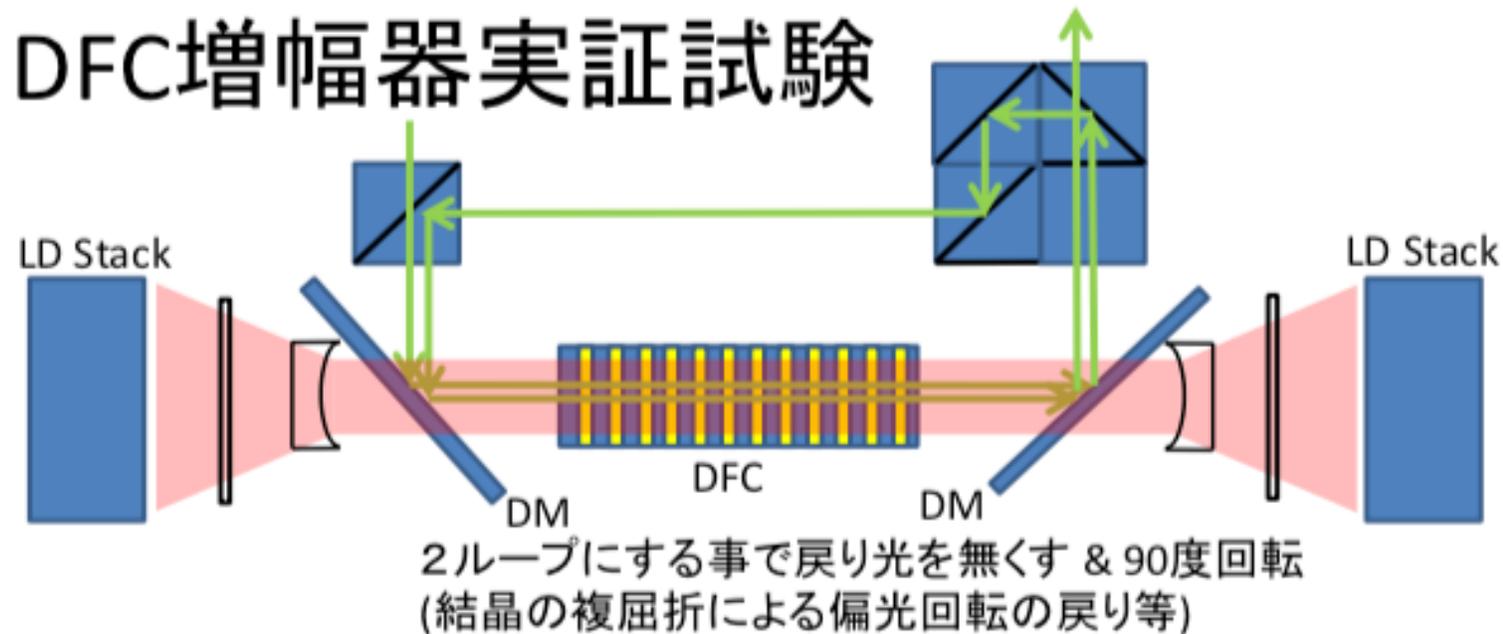
$$Q(x, y, z) = \frac{P_{in} \cdot \eta_h \cdot \alpha(z)}{\pi w^2} \cdot e^{-\int_0^l \alpha(z) \cdot dz}$$

* Y. Sato et al. in *IEEE JQE*, vol. 40, pp. 270-280 (2004)

Simulated temperature distribution



DFC増幅器実証試験



- 増幅率

- 8 kW x 4 (両方向On-Axis励起) x 250 μ s = 8 J / cm²

- G= 5 for L(Nd:YAG) = 1.3cm(1/e²) (2-passで50倍)

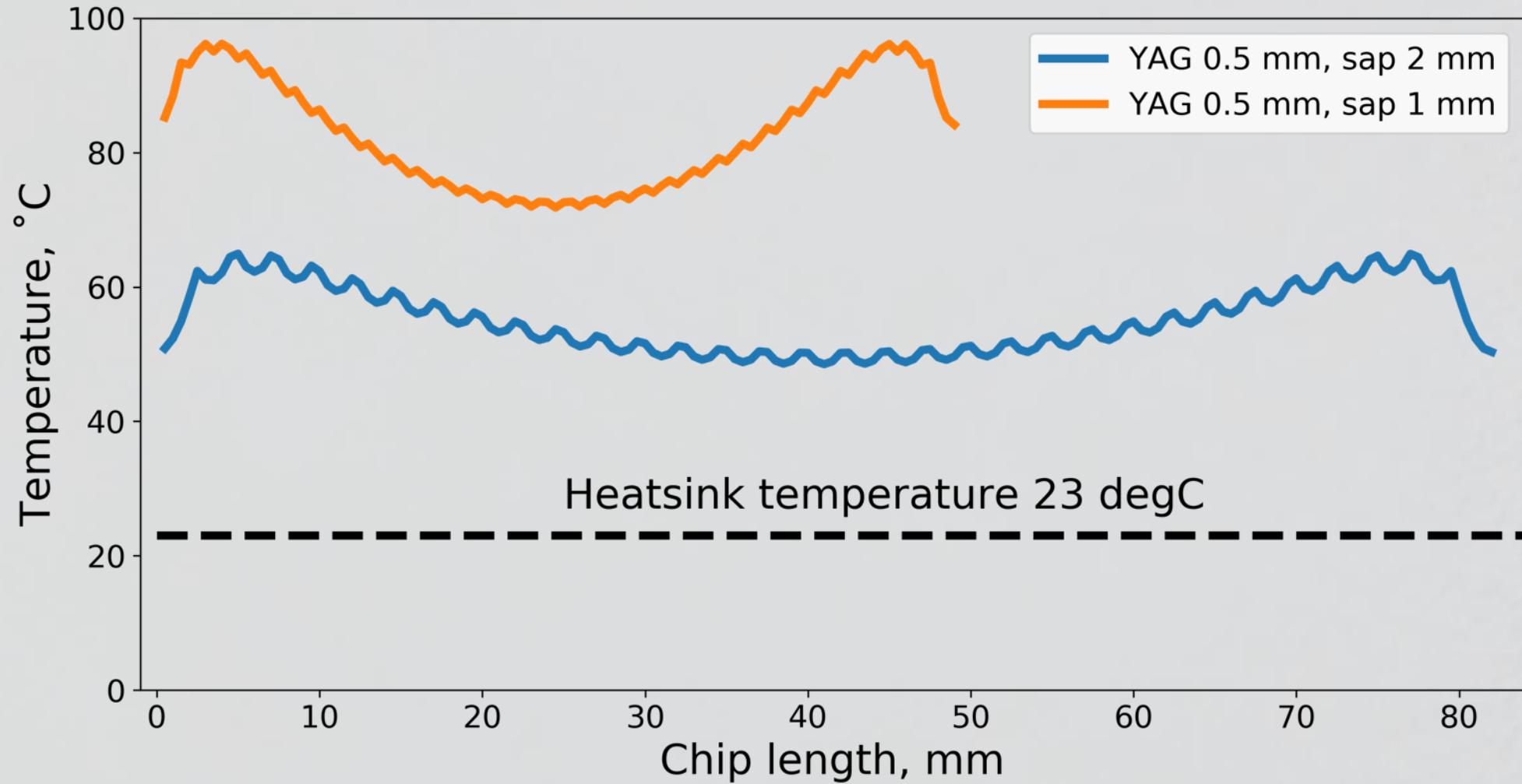
- Pump(885nm)

- 4 stack(32kW, 8J)

- Output

- 2 J → 1 J @ SHG

Future work. Simulated temperature distribution



Conclusion

- **DFC** concept is originally developed by SAB for **Handheld Intense Tiny Integrated Laser (HITILA)**
 - micro-laser energy scaling
 - sub-nanosecond (sub-ns) pulse duration
- We produced composite crystals for CW and Q-switch operation by SAB. The interface between crystal was coated and helped to increase pump absorption efficiency.
- By use 19-crystal DFC chip, amplification up to 300 mJ at 50 Hz repetition rate was achieved.
- We are working towards optimization of amplifier setup and DFC chip in order to achieve 2 J amplifier laser at 100 Hz repetition rate